- **For applications in:**
  Digital Computer Systems
  Data-Handling Systems
  Control Systems
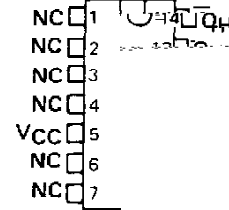
TYPE	TYPICAL MAXIMUM CLOCK FREQUENCY	TYPICAL POWER DISSIPATION
'91A	18 MHz	175 mW
'LS91	18 MHz	60 mW

description

These monolithic serial-in, serial-out, 8-bit shift registers utilize transistor-transistor logic (TTL) circuits and are composed of eight R-S master-slave flip-flops, input gating, and a clock driver. Single-rail data and input control are gated through inputs A and B and an internal inverter to form the complementary inputs to the first bit of the shift register. Drive for the internal common clock line is provided by an inverting clock driver. This clock pulse inverter/driver causes these circuits to shift information one bit on the positive edge of an input clock pulse.

SN5491A, SN54LS91 . . . J PACKAGE
SN7491A . . . N PACKAGE
SN74LS91 . . . D OR N PACKAGE
(TOP VIEW)

```
       ___ ___
NC  1 |   U   | 14  Q_H
NC  2 |       | 
NC  3 |       |
NC  4 |       |
VCC 5 |       |
NC  6 |       |
NC  7 |       |
      |_____|
```

SN5491A, SN54LS
(TOP

```
       ___ ___
NC  1 |   (   |
NC  2 |       |
NC  3 |       |
VCC 4 |       | 11  GND
NC  5 |       | 10  A
NC  6 |       |  9  CLK
NC  7 |       |  8  NC
      |_____|
```
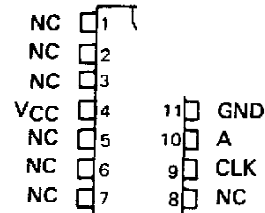
NC - No internal connection

schematics of inputs and outputs

FUNCTION TABLE

INPUTS AT t_n		OUTPUTS AT t_{n+8}	
A	B	Q_H	$\overline{Q_H}$
H	H	H	L
L	X	L	H
X	L	L	H

t_n = Reference bit time, clock low

t_{n+8} = Bit time after 8 low-to-high clock transitions.

logic symbol†

CLK (9) ▷C1/→
B (11)
A (12) & 1D
(13) Q_H
(14) $\overline{Q_H}$
SRG8
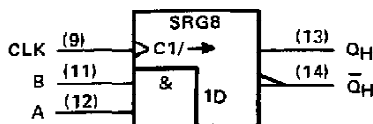
†This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.
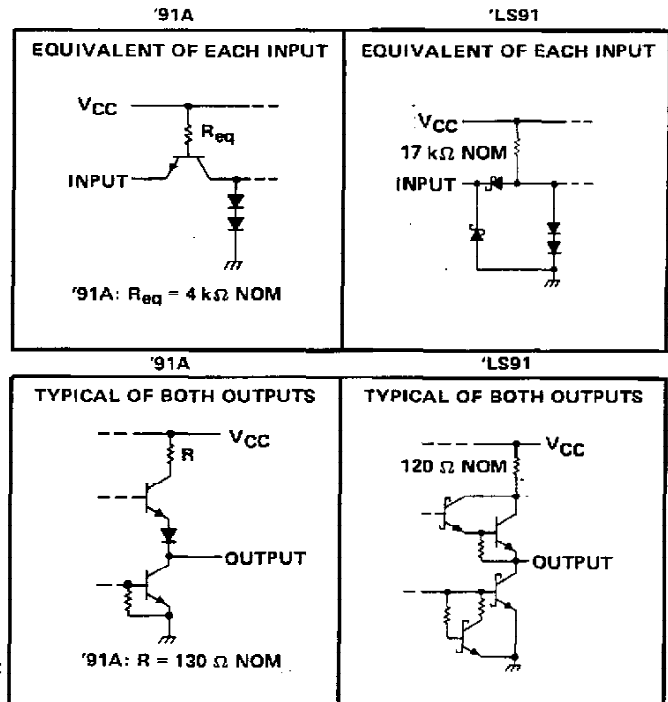
'91A — EQUIVALENT OF EACH INPUT
VCC — R_eq — INPUT
'91A: R_eq = 4 kΩ NOM

'LS91 — EQUIVALENT OF EACH INPUT
VCC — 17 kΩ NOM — INPUT

'91A — TYPICAL OF BOTH OUTPUTS
VCC — R — OUTPUT
'91A: R = 130 Ω NOM

'LS91 — TYPICAL OF BOTH OUTPUTS
VCC — 120 Ω NOM — OUTPUT

SN5491A, SN7491A
8-BIT SHIFT REGISTERS

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logic diagram (positive logic)
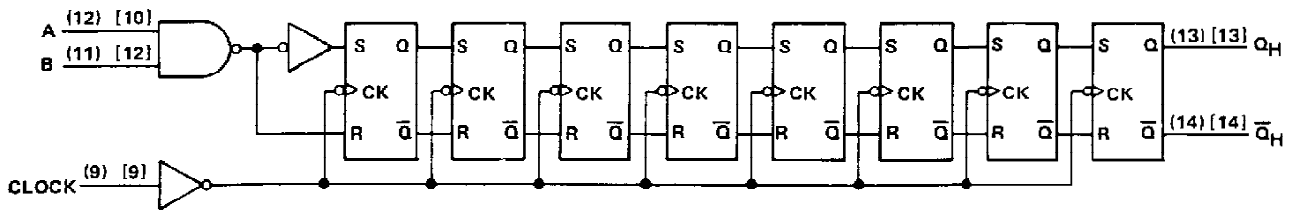
Pin numbers shown in ( ) are for the D, J or N packages and pin numbers shown in [ ] are for the W package.

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V_{CC} (see Note 1) . . . . 7 V
Input voltage (see Note 2) . . . . 5.5 V
Operating free-air temperature range: SN5491A . . . . −55°C to 125°C
                                    SN7491A . . . . 0°C to 70°C
Storage temperature range . . . . −65°C to 150°C

NOTES: 1. Voltage values are with respect to network ground terminal.
         2. Input signals must be zero or positive with respect to network ground terminal.

recommended operating conditions

	SN5491A			SN7491A			UNIT
	MIN	NOM	MAX	MIN	NOM	MAX	
Supply voltage, V_{CC}	4.5	5	5.5	4.75	5	5.25	V
High-level output current, I_{OH}			−400			−400	μA
Low-level output current, I_{OL}			16			16	mA
Width of clock input pulse, t_w	25			25			ns
Setup time, t_{su} (see Figure 1)	25			25			ns
Hold time, t_h (see Figure 1)	0			0			ns
Operating free-air temperature, T_A	−55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS[†]	SN5491A			SN7491A			UNIT
			MIN	NOM	MAX	MIN	NOM	MAX	
V_{IH}	High-level input voltage		2			2			V
V_{IL}	Low-level input voltage				0.8			0.8	V
V_{OH}	High-level output voltage	V_{CC} = MIN, V_{IH} = 2 V, V_{IL} = 0.8 V, I_{OH} = −400 μA	2.4	3.5		2.4	3.5		V
V_{OL}	Low-level output voltage	V_{CC} = MIN, V_{IH} = 2 V, V_{IL} = 0.8 V, I_{OL} = 16 mA		0.2	0.4		0.2	0.4	V
I_I	Input current at maximum input voltage	V_{CC} = MAX, V_I = 5.5 V			1			1	mA
I_{IH}	High-level input current	V_{CC} = MAX, V_I = 2.4 V			40			40	μA
I_{IL}	Low-level input current	V_{CC} = MAX, V_I = 0.4 V			−1.6			−1.6	mA
I_{OS}	Short-circuit output current[§]	V_{CC} = MAX	−20		−57	−18		−57	mA
I_{CC}	Supply current	V_{CC} = MAX, See Note 3		35	50		35	58	mA

[†]For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.
[‡]All typical values are at V_{CC} = 5 V, T_A = 25°C.
[§]Not more than one output should be shorted at a time.
NOTE 3: I_{CC} is measured after the eighth clock pulse with the output open and A and B inputs grounded.

switching characteristics, V_{CC} = 5 V, T_A = 25°C

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
f_{max}	Maximum clock frequency	C_L = 15 pF,	10	18		MHz
t_{PLH}	Propagation delay time, low-to-high-level output	R_L = 400 Ω,		24	40	ns
t_{PHL}	Propagation delay time, high-to-low-level output	See Figure 1		27	40	ns

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V_{CC} (see Note 1) . . . . 7 V
Input voltage . . . . 7 V
Operating free-air temperature range: SN54LS91 . . . . −55°C to 125°C
                                  SN74LS91 . . . . 0°C to 70°C
Storage temperature range . . . . −65°C to 150°C

NOTES: 1. Voltage values are with respect to network ground terminal.

recommended operating conditions

	SN54LS91			SN74LS91			UNIT
	MIN	NOM	MAX	MIN	NOM	MAX	
Supply voltage, V_{CC}	4.5	5	5.5	4.75	5	5.25	V
High-level output current, I_{OH}			−400			−400	μA
Low-level output current, I_{OL}			4			8	mA
Width of clock input pulse, t_w	25			25			ns
Setup time, t_{su} (see Figure 1)	25			25			ns
Hold time, t_h (see Figure 1)	0			0			ns
Operating free-air temperature, T_A	−55		125	0		70	C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS†		SN54LS91			SN74LS91			UNIT
				MIN	TYP‡	MAX	MIN	TYP‡	MAX	
V_{IH}	High-level input voltage			2			2			V
V_{IL}	Low-level input voltage					0.7			0.8	V
V_{IK}	Input clamp voltage	V_{CC} = MIN,	I_I = −18 mA			−1.5			−1.5	V
V_{OH}	High-level output voltage	V_{CC} = MIN, V_{IH} = 2 V, V_{IL} = V_{IL} max, I_{OH} = −400 μA		2.5	3.5		2.7	3.5		V
V_{OL}	Low-level output voltage	V_{CC} = MIN, V_{IH} = 2 V, V_{IL} = V_{IL} max	I_{OL} = 4 mA		0.25	0.4		0.25	0.4	V
			I_{OL} = 8 mA					0.35	0.5	
I_I	Input current at maximum input voltage	V_{CC} = MAX,	V_I = 7 V			0.1			0.1	mA
I_{IH}	High-level input current	V_{CC} = MAX,	V_I = 2.7 V			20			20	μA
I_{IL}	Low-level input current	V_{CC} = MAX,	V_I = 0.4 V			−0.4			−0.4	mA
I_{OS}	Short-circuit output current§	V_{CC} = MAX		−20		−100	−20		−100	mA
I_{CC}	Supply current	V_{CC} = MAX,	See Note 3		12	20		12	20	mA

†For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.
‡All typical values are at V_{CC} = 5 V, T_A = 25 C.
§Not more than one output should be shorted at a time, and duration of the short-circuit should not exceed one second.
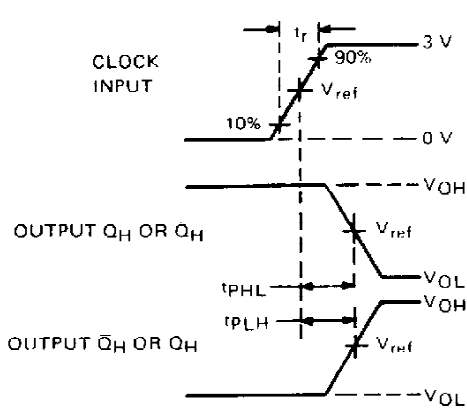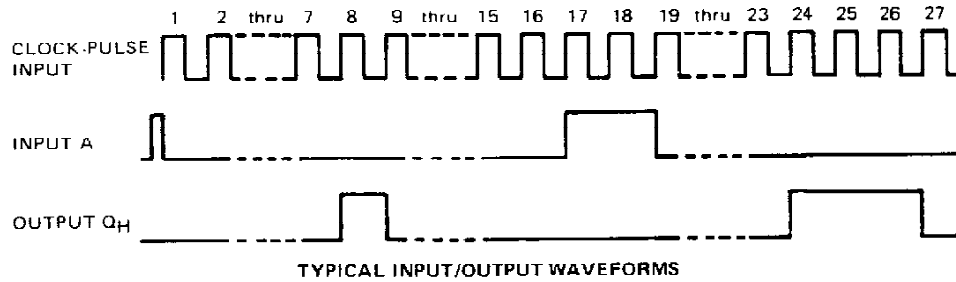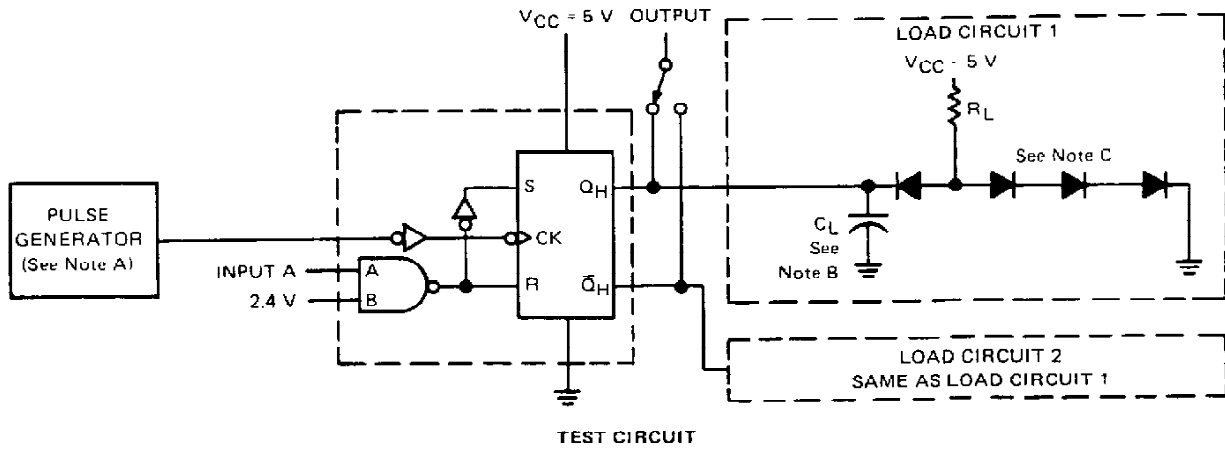NOTE 3: I_{CC} is measured after the eighth clock pulse with the output open and A and B inputs grounded.

switching characteristics, V_{CC} = 5 V, T_A = 25°C

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
f_{max}	Maximum clock frequency	C_L = 15 pF, R_L = 2 kΩ, See Figure 1	10	18		MHz
t_{PLH}	Propagation delay time, low-to-high-level output			24	40	ns
t_{PHL}	Propagation delay time, high-to-low-level output			27	40	ns

PARAMETER MEASUREMENT INFORMATION

TEST CIRCUIT

TYPICAL INPUT/OUTPUT WAVEFORMS

PROPAGATION DELAY TIMES VOLTAGE WAVEFORMS

SWITCHING TIMES VOLTAGE WAVEFORMS

NOTES: A. The generator has the following characteristics: $t_{w(clock)}$ = 500 ns, PRR ≤ 1 MHz, Z_{out} ≈ 50 Ω. For SN5491A/SN7491A, t_r ≤ 10 ns and t_f ≤ 10 ns; for SN54LS91, t_r = 15 ns, and t_f = 6 ns.
   B. C_L includes probe and jig capacitance.
   C. All diodes are 1N3064 or equivalent.
   D. For SN5491A/SN7491A, V_{ref} = 1.5 V; for SN54LS91/SN74LS91, V_{ref} = 1.3 V.

FIGURE 1—SWITCHING TIMES

TEXAS
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